## Application/Control No. O9/660,917 Applicant(s)/Patent Under Reexamination WENDT ET AL. Examiner Dean O Takaoka Applicant(s)/Patent Under Reexamination WENDT ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,965,712	10-1990	Duspiva et al.	363/126
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	D	US-			
	E	US-			
	F	US-			
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	I	US-			
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-"	К	US-			
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## **NON-PATENT DOCUMENTS**

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